

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/807,455 | Applicant(s)/Patent Under Reexamination CHONAN ET AL. | |
| | Examiner David D. Le | Art Unit 3681 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| | A | US-4,504,247 | 03-1985 | Chana et al. | 474/17 |
| | B | US-6,755,090 B2 | 06-2004 | Ima, Akihiro | 74/330 |
| | C | US-2005/0119076 A1 | 06-2005 | Chonan et al. | 474/029 |
| | D | US-4,458,318 | 07-1984 | Smit et al. | 701/51 |
| | E | US-4,602,525 | 07-1986 | Moroto et al. | 475/210 |
| | F | US-6,875,152 B2 | 04-2005 | Iwatuki et al. | 477/44 |
| | G | US-4,392,394 | 07-1983 | Hofbauer et al. | 475/204 |
| | H | US-4,560,369 | 12-1985 | Hattori, Torao | 474/28 |
| | I | US-4,304,150 | 12-1981 | Lupo et al. | 475/51 |
| | J | US-6,902,502 B2 | 06-2005 | Murakami et al. | 474/23 |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|-----------------|----------------|
| | N | JP 04285354 A | 10-1992 | Japan | MORISAWA, KUNIO | F16H 37/02 |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.